Electrical and Magnetic Properties of Quaternary Rare Earth Thiophosphates: K₄Sm₂[PS₄]₂[PS₆]₄

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O tiofosfato quaternário de metal alcalino e terra rara K₄Sm₂[PS₄]₂[PS₆]₄ foi sintetizado pelo método cerâmico e caracterizado por difratometria de raios X de pó (XRD), microscopia eletrônica de varredura com microanálise de raios X (SEM-EDX), medidas de impedância eletroquímica e medidas magnéticas. A estrutura cristalina consiste de camadas de [PS₄]²⁻ separadas por cátions K⁺. As medidas de condutividade elétrica indicam que o composto é um semicondutor com uma resistividade de 1,0 x 10⁶ Ω cm. O momento magnético, obtido a partir de χ⁻¹ versus T a baixa temperatura, é igual a 0,57 μ₀.

The quaternary alkali metal, rare earth thiophosphate phase K₄Sm₂[PS₄]₂[PS₆]₄ was synthesized by ceramic method and characterized by powder X-ray diffraction (XRD), SEM-EDX scanning electron microscope-microprobe analyses, electrochemical impedance and magnetic measurements. The crystal structure consists of layers of [PS₄]²⁻ separated by K⁺ cations. The electrical conductivity measurements indicate that the compound is a semiconductor with a resistivity of 1.0 x 10⁶ Ω cm. The magnetic moment, evaluated from χ⁻¹ versus T at low temperature is 0.57 μ₀.

Keywords: thiophosphate, electrical properties, magnetic properties

Introduction

The study on chalcophosphates of the type AMₙPₚQ₂ (where A and M are metals and Q = S, Se) deserves a strong attention due to their anisotropic physical properties, as thermoelectric and nonlinear optics behaviors. Moreover, these phases present a great variety of structures in the solid state. A structural representation considers them as salts formed by the ions A⁺M⁻ and PₚQ₂⁻. They possess the structural anionic units PₚQ₂⁻, with chalcogen-phosphorus bonds, coordinated to the metals A and M through chalcogen atoms Q. The present investigation on chalcophosphate compounds has been oriented to the synthesis of quaternary phases to form salts, taking advantage of the flexibility and stability of the anions PₚQ₂⁻ (Q = S, Se) and their capability to form compounds with cations in several oxidation states.

Many quaternary rare-earth metal thiophosphates have been prepared and characterized structurally. Examples of reported rare-earth thiophosphates include phases such as: K₄Yb₂(PS₄)₂, Li₂Nd₂(PS₄)₆, K₂Gd₄(PS₄)₁₂, and K₂Gd₄(PS₄)₁₂, K₂Ce₄PS₄, Na₂(RE)P₆S₁₆ (RE = Y, Sm) and K₂Nd₄PS₆, K₂Nd₄PS₆, Na₂Er₄PS₆, and Cs₄Er₄(PS₄)₁₂. These compounds present [PS₄]²⁻, [P₂S₆]⁴⁻ and [P₂S₆]⁴⁻ anions coordinated to the metal rare-earth ions through sulfur atoms.

In the course of our work on quaternary heterocharged metal thiophosphates we have previously reported the crystal structures of the layered phases KMP₄S₆ (M = Bi, Sb) and the α- and β-phases of NaSbP₂S₆. In these phases the layers are formed by ethane-like anions [P₂S₆]⁴⁻ bridging the M₄⁺ metal atoms, which are held together by layers of alkali cations. Our investigation of quaternary systems containing alkali metals, rare-earths (3⁺), phosphorus and sulfur has yielded a new samarium thiophosphate: K₄SmP₂S₆, which contains the anionic units [P₂S₆]⁴⁻ and [PS₄]²⁻. We report herein the electrical and magnetic properties of this quaternary samarium thiophosphate compound.

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Experimental

The preparation of the phase $K_2SmP_2S_7$ was carried out by direct combination, in stoichiometric amounts, of powders of the corresponding high purity elements (99.99%, Aldrich). The reaction mixture was sealed in evacuated quartz ampoules and placed in a programmable furnace. All manipulations were carried out under Ar atmosphere. The mixture was heated to 800 °C at 10 °C h⁻¹. After five days, the reacted matter was slowly cooled to room temperature at a rate of 6 °C h⁻¹. The ampoule was opened to reveal a formation of yellow crystals. The reaction mixture was washed with DMF and anhydrous ether. (Found values: K, 15.66; Sm, 29.43; P, 11.22; S, 43.69%. Calculated values: K, 15.19; Sm, 29.20; P, 12.03; S, 43.58%). The product appeared to be air and moisture stable over several weeks.

The X-ray diffraction (XRD) data were collected at room temperature with a Siemens D-5000 X-ray powder diffractometer, using Cu-$K_a$ radiation in the range $5^\circ < 2\theta < 60^\circ$. Qualitative comparison of the experimental powder pattern with calculated powder pattern of known crystal structure was performed. Elemental analysis confirming the chemical composition of the powder was obtained from energy dispersive spectroscopy (EDS) on a JEOL 6400 scanning electron microscope system equipped with an Oxford LinK ISIS microanalyzer. Differential thermal analysis (DTA) and thermogravimetric analysis (TGA) were performed on a Rheometric Scientific STA 1500H/625 thermal analysis system. The DTA/TGA curves were run simultaneously on each sample from room temperature to 1000 °C, in flowing nitrogen at a heating rate of 10 °C min⁻¹.

The electrical properties were studied by dc current-voltage measurements using a Keithley model 237 source-electrometer and by impedance-frequency analysis using a Solartron Instruments model 1260 analyzer. 156.5 mg of powder were pressed at ca. 3.92 tons (927 MPa) for 30 s, resulting in a pellet of 7.27 mm diameter and thickness of 1.35 mm, corresponding to an average density of 2.79 g cm⁻³. Gold electrodes, 10 nm thick, were deposited by sputtering.

The magnetic measurements were performed on a Quantum Design MPMS XL5 SQUID magnetometer, under a static field of 2.5 kOe and with increasing temperatures from 2 K up to 300 K. 134.9 mg of powdered sample were placed inside a gelatin capsule, of which the diamagnetic contribution (less than 3% at room temperature) was subtracted from the overall signal.

Results and Discussion

We have previously reported the crystal structures of the layered phases of a new samarium thiophosphate $K_2Sm_3[PS_4]_2[P_2S_6]$. A description of the structure is briefly recalled here. The phase $K_2SmP_2S_7$ has a two-dimensional layered structure as shown in Figure 1. The layered structure contains Sm$^{3+}$ ions coordinated by three [PS$_4$]$^{3-}$ and one [P$_2$S$_6$]$^{4-}$ anions. There are two crystallographically different K$^+$ cations coordinated to S atoms. The packing of $K_2SmP_2S_7$ is formed by $[Sm_3[PS_4]_2[P_2S_6]]^{4+}$ layers, in the $ab$-plane, separated by K$^+$ cations.

![Figure 1. Crystal structure of $K_2SmP_2S_7$ down the b-axis.](image1)

The monolayer of Sm$^{3+}$ cations arrangement can be seen as a graphite-like configuration in the zig-zag chain pattern, as shown in Figure 2. The closest Sm-Sm distance within the layers is 5.307 Å.

![Figure 2. Arrangement of Sm$^{3+}$ cations in one layer.](image2)

The X-ray powder diffractograms (XRD) of the $K_2SmP_2S_7$ phase show sharp lines that reflect the crystallinity and homogeneity. The XRD was completely indexed, and the observed interplanar spacing showed a good agreement with that calculated from the crystal structure. Elemental analysis was carried out, which, together with the sharp XRD pattern, evidences the purity of the studied samples.
The differential thermal and thermogravimetric analyses (DTA/TGA) showed a slight weight loss of approximately 5% in the interval 37-550 °C, which may be assigned to partial sulfur loss. Then, the mass continues to reduce until the temperature reaches 1000 °C. The DTA exhibited a sharp exothermic peak at 550 °C. These results are shown in Figure 3. The first stage of decomposition can be attributed to the partial sulfur loss. In a second stage, at 550 °C, the thiophosphate phase decomposes to sulphides and phosphides, which were identified by XRD analysis of the residues.

Before electrical characterization the pellet was mounted in the test chamber, and the assembly was evacuated (below 10⁻⁴ mbar) for 1 h, at ambient temperature. Cycling the bias over ±100 V at 1 V s⁻¹ leads to a hysteresis of 0.41 nA, at V = 0, between the negative-going and the positive-going branches at 312 K. This amount to 3.8% of the current span from −100 to +100 V. Otherwise, the I-V curves are essentially linear. At higher bias, sweeping from −100 to +1100 V, the I-V curves bend slightly upwards, conforming to a space-charge limited current model, (I ∝ Vⁿ), with n = 1.13, over the 100 to 1100 V range. The resistance of 3.29 x 10¹⁰ Ω, in the ±100 V range, corresponds to a resistivity of 1.0 x 10¹⁴ Ω cm. Temperature variations over a narrow range (ambient to 313 K) indicates a semiconductor-like temperature dependence of the resistivity.

The impedance (R + jX)-frequency measurements, where j = (-1)¹/² (Figure 4), display approximately one half of a semicircle in the Nyquist plot. Data scatter, due to high impedance, restricts the measurements to frequencies above 1 Hz. These data have been analyzed using the equivalent circuit program, by B. Boukamp (version 2.0), assuming the parallel combination of a resistor (R), a constant phase element (CPE, of impedance (Yₑ) = 1/(jωCPE)), and a carrier diffusion process with permeable boundaries (of impedance tanh(B(jω))²)⁻¹. Assuming permeable boundaries, with Pt electrodes, implies assuming electronic conduction as the dominant charge transport process.

The fit achieves a χ² quality of 1.9 x 10⁻³, with values of R = 2.3 x 10¹⁰ (± 20%) Ω, Yₑ = 2.12 x 10⁻¹² (± 4%) pFs⁻¹, n = 0.976 (± 0.3%), Yₑ = 2.8 x 10⁻¹¹ (± 4%) Ω⁻¹, and B = 0.6 (± 87%) s¹/². The value of R, together with the parameters of the CPE, and an estimate of the frequency at which the maximum of (−X) would occur, lead to a value of 8 for the effective relative dielectric permittivity,¹⁹ suggesting that the charge transport belongs to the interior of the material grains. This is supported too by the value of n, so close to 1, indicating that the charge transport is rather homogeneous, i.e., there is not a complex network of carrier paths, as would be the case for intergrain transport. Within this interpretation, the value of R corresponds to a bulk resistivity of 1.0 x 10¹⁴ Ω cm, and it accounts for approximately two thirds of the dc resistance (3.3 x 10¹⁰ Ω).

The remaining resistance is due, most likely, to the transport at intergrain boundaries. This expectation comes from the loose arrangement of grains in the pellets, which were not sintered after pressing, since that process would degrade the material. The resulting scant grain-to-grain contact should lead to high intergrain impedance. Finally, the parameters of the diffusion model depend on the diffusion length, the diffusion coefficient, and on the response of the carrier concentration upon the oscillating electrodes potential. These factors are fully beyond the scope of current work, so, the parameters B and Yₑ have not been related to physical properties of the material.

The band gap analysis, using UV-Vis diffuse reflectance spectroscopy, indicates that K₃SmP₂S₁₀ has an energy gap of 2.59 eV.¹⁷ These values are expected for yellow compounds. For comparison, the corresponding band gaps of NaSmP₂S₁₀ is 2.54 eV.¹⁰

Figure 5 shows the thermal dependence of the product [susceptibility*temperature]. The temperature-independent contribution to the magnetic susceptibility, as deduced from the slope of the χ*T versus T plot, is due to the admixture between the ²H₆/₂ and the ²H₅/₂ multiplets of the Sm²⁺ ion.
and it is known as the Van Vleck susceptibility, $\chi_{VV}$. A value for $\chi_{VV}$ of $2.98 \times 10^{-3}$ emu mol$^{-1}$ was estimated in the high-temperature linear region (150-300 K) in Figure 5. The Figure 6 shows the experimental magnetic susceptibility (black dots) and the one obtained after subtraction of the temperature-independent paramagnetic Van Vleck $\chi_{VV}$ term (open symbols).

Assuming that at low temperature the $^6H_{5/2}$ level is situated far from the higher energy states, an estimation of the effective magnetic moment can be done at the lowest available temperature range. For this, we have plotted in the insert of Figure 6 the inverse magnetic susceptibility of the corrected data. These data extrapolate to $T = 0$, which means that no magnetic interactions can be expected between Sm spins. The low temperature slope can be considered then as a good approximation to the effective magnetic moment. In our case, we have taken the data in the range between 2 and 15 K (insert, Figure 6) and calculated a magnetic moment of $0.57 \mu_B$ which corresponds quite reasonably to the expected moment for non correlated Sm$^{3+}$ spins ($\mu_{\text{theo}} = g \sqrt{J(J+1)} = 0.85 \mu_B; g = 2/7$). This result excludes the possibility of a divalent oxidation state for samarium which will give a null moment (Sm$^{2+}$; $^7F_0$ state, $g = J = 0, \mu_{\text{eff}} = 0$).

Conclusions

In summary, we have prepared quaternary alkali rare earth thiophosphate phase $K_4\text{Sm}_2[PS_4]_2[P_2S_6]$ by ceramic method. The thermal stability was verified and no phase transition was observed. The current-voltage characteristics and their temperature dependence over a narrow temperature range indicate semiconductor temperature activation of the conductivity. The electrochemical impedance measurements indicate that the bulk (interior) of the compound grains present a resistivity of $1.0 \times 10^{11} \Omega \text{cm}$, and effective relative dielectric permittivity of 8, suggesting a dependence on bulk, intragrain charge transport. Magnetic measurement indicated that samarium is at its +III oxidation state, with an evident admixture of the fundamental $^6H_{5/2}$ state with higher energy levels.

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References